

We would like to invite you to the training course

**X-RAY PHOTOELECTRON SPECTROSCOPY: FROM MEASUREMENTS TO
SCIENTIFIC ANSWERS
(using software casaXPS)**

Dr. Vincent Fernandez

Institute des Matériaux Jean Rouxel IMN, Nantes, France

Mon 30. 11. 2015 10 am – 13 pm Analysis of XPS overview spectra and start with casaXPS

Tue 1. 12. 2015 9 am – 12 noon Instrumental quantification and quantification of uncertainties of data fitting

Thu 3. 12. 2:30 pm – 5:30 pm Training on fitting with vectorial technique (related to the seminar talk)

Fri 4. 12. 2015 9 am – 12 noon Advanced fitting, angular analysis, imaging and charging effects

Place: CEITEC, building of Technology park B3, Podnikatelská 6, Brno

Number of participants is limited. Please register by email to lenkaz@physics.muni.cz (Assoc. Prof. Lenka Zajíčková) with the notice which courses you would like to attend. The participants attending more courses will be preferred.

Take your laptop and headset. The training will be based on videos and hands-on practice. In case of need, a limited number of PCs (without headsets) will be available.